

Supporting information for Spiral layer undulation defects in B7 liquid crystals

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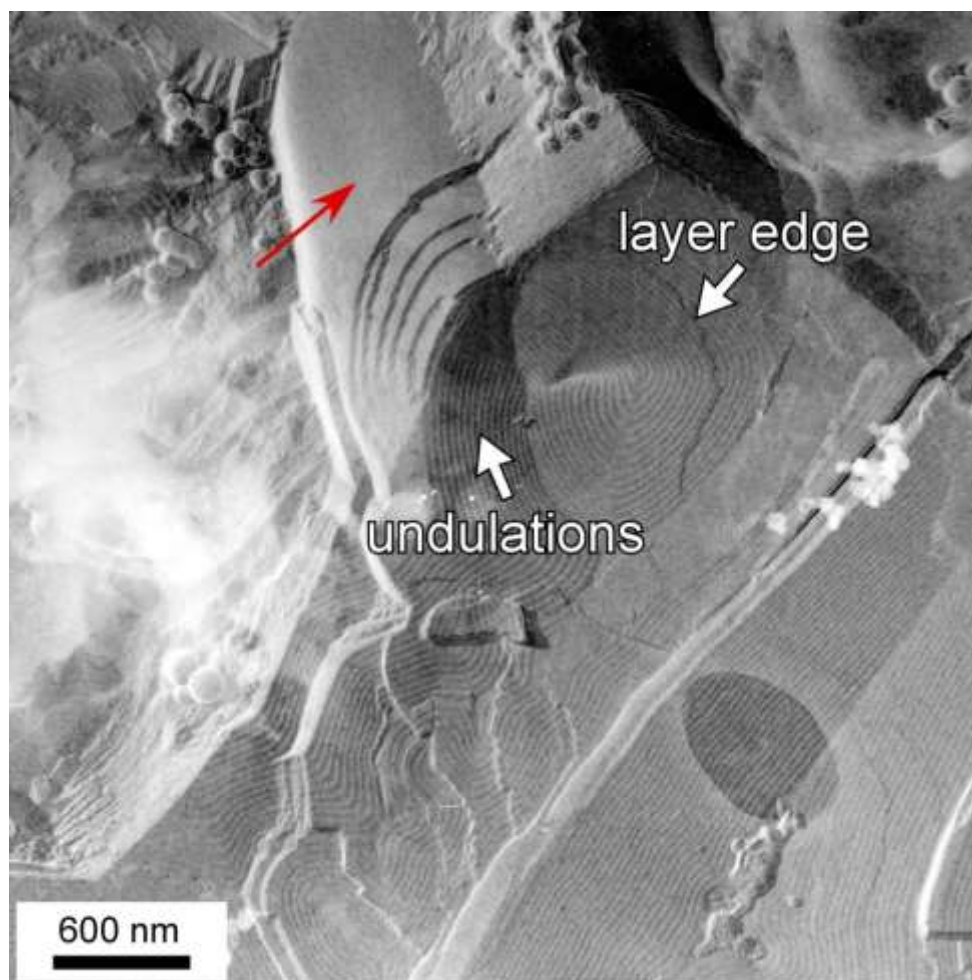


Figure S.1: FFTEM image of MHOBOW quenched at $T=100^{\circ}\text{C}$ and then fractured in the bulk. It is evident that the sample tends to fracture along the layer undulations (red arrow), indicating that the polarization modulation stripes have distinct boundaries.